Application/Control No. Applicant(s)/Patent Under Reexamination 10/677,257 INOUE, SATOSHI Notice of References Cited Art Unit Examiner Page 1 of 1 Michael Trinh 2822 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,830,787 11-1998 Kim, Hong Seuk 438/163 US-5,569,935 10-1996 Takemura et al. R 257/51 US-C US-D US-Ε US-F US-G US-Н US-US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS . **Document Number** Date Country . Name Country Code-Number-Kind Code MM-YYYY Classification Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ w Х

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